

IIT MADRAS Technology Transfer Office TTO - IPM Cell



Industrial Consultancy & Sponsored Research (IC&SR)

# DYNAMIC LOAD SLIDING CONTACT TRIBOMETER AND METHOD TO SIMULATE WEAR THEREWITH

# **IITM Technology Available for Licensing**

## Problem Statement

Indian Institute of Technology Madras

- Appearance of white etching area followed by white etching cracks (WECs) formation is observed dominant mode as а of **premature failure** in rolling element bearings of wind turbine gearboxes, automobiles, vertical roller mills of cement industry and other components.
- In this instance a few patent literature discussed a few remedies however said prior arts includes the limitations as lack of cyclic loading to reproduce service conditions of bearings, large number of contact cycles required (>10 million cycles), difficulty in determining WEC in a large specimen.
- Hence, there is a need to mitigate above challenges & provide efficient solution.

## Technology Category/Market

Technology: Simulate accelerated wear of mating steel components; Industry: Manufacturing, Instruments;

Applications: : Manufacturing, Instruments;

Market: The global Tribometer market is projected to \$1.48B by 2030, at a CAGR of 4.5% during 2023-2030.

### Intellectual Property

IITM IDF Ref.: 1568; IN Patent No. 386008

TRL (Technology Readiness Level)

TRL- 4: Technology validated in Lab

## **Research Lab**

Prof. Ramkumar P, Advanced Tribology Research Lab, Dept. of Mechanical Engineering

## Technology

Present Patent discloses a dynamic load sliding contact tribometer configured to simulate accelerated wear of mating steel components.

## **CONTACT US**

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- Further the said dynamic load sliding contact tribometer comprises a motor-powered rotatable disc sample configured to operate at a predetermined speed of rotation; a pin holder configured to hold a pin sample in sliding contact with the disc sample; & a cyclic load generator configured to transfer a cyclic load to the pin sample via a lever arm & generate a contact pressure.
- The lever arm having a first end & a second end, & pivoted at a fixed hinge therebetween, the first located end connected to the pin holder & the second end connected to the cyclic load generator.
- Further, the wear of the disc or the pin sample is adjustable by varying maximum pressure (upto 4GPa) generated at the cyclic load generator. The load cycling is variable in the range of 1-60Hz.
- Further, tribometer comprises а linear variable differentia transducer configured to measure combined wear **depth** of the pin with reference to the disc sample.
- A method of simulating accelerated wear on a steel sample due to Hydrogen induced white etching area formation using a pin-on-disc tribometer shown in flowchart.

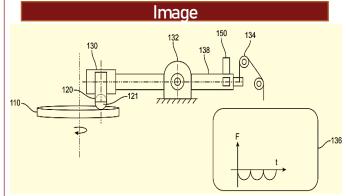


Fig.1: Illustrates side view of a tribometer.

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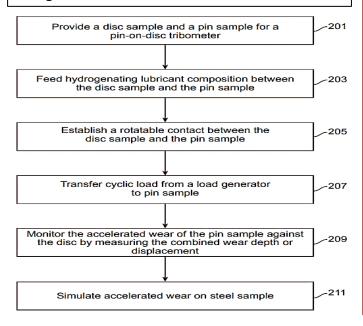
# IIT MADRAS Technology Transfer Office Indian Institute of Technology Madras



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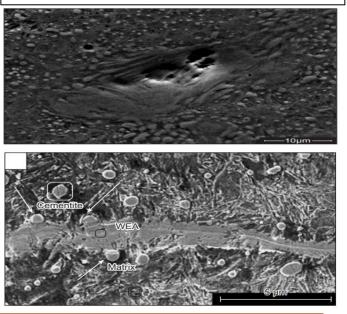
### Flowchart

FIG.2: depicts a flowchart of a method of simulating accelerated wear on a steel sample using a tribometer



### Experimental Results

FIG. 3 depicts the SEM image of WEA formation due to cementite dissolution. Fig 4 depicts the EDS image of WEA formation due to cementite dissolution.



# Key Features / Value Proposition

## \* Technical Perspective:

- The pin and the disc samples are of bearing steel and accelerated wear is indicated by cementite phase dissolution & formation of white etching area (WEA) in the subsurface of the **pin sample** or the **disc sample**.
- The WEA is obtained in a test duration of 40 h or less.
- The accelerated wear is obtained in 3x10<sup>5</sup> contact cycles or less.
- \* The sample includes a gear, roller bearing element, or a ball bearing element.

### \* Industrial Perspective:

- Applicable in Instrumentation Industries, Manufacturing Industries. (Refer result shown) in Table.
- Test rig used in the various studies and the typical contact cycle to create WEA/WECs as given in Table. Table 1

No	Test rig	Number of cycles to form WEA/WECs
1	FE8 test rig	$1 \times 10^{7}$
2	RDM	$38 \times 10^{7}$
3	Two roller test rig	$4,2 \times 10^7$ $40 \times 10^6$
4	Pre-hydrogenation and two roller tester	$40 \times 10^{6}$
5	This invention	$2,15 \times 10^{5}$

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